

## Accepted Manuscript

Title: Grain size measurement in optical microstructure using support vector regression

Authors: K. Gajalakshmi, S. Palanivel, N.J. Nalini, S. Saravanan, K. Raghukandan



PII: S0030-4026(17)30312-1  
DOI: <http://dx.doi.org/doi:10.1016/j.ijleo.2017.03.052>  
Reference: IJLEO 58975

To appear in:

Received date: 2-9-2016  
Accepted date: 13-3-2017

Please cite this article as: Gajalakshmi K., Palanivel S., Nalini N.J., Saravanan S., Raghukandan K., Grain size measurement in optical microstructure using support vector regression, *Optik - International Journal for Light and Electron Optics* <http://dx.doi.org/10.1016/j.ijleo.2017.03.052>

This is a PDF file of an unedited manuscript that has been accepted for publication. As a service to our customers we are providing this early version of the manuscript. The manuscript will undergo copyediting, typesetting, and review of the resulting proof before it is published in its final form. Please note that during the production process errors may be discovered which could affect the content, and all legal disclaimers that apply to the journal pertain.

## GRAIN SIZE MEASUREMENT IN OPTICAL MICROSTRUCTURE USING SUPPORT VECTOR REGRESSION

**K. Gajalakshmi<sup>1</sup>, S. Palanivel<sup>1</sup>, N.J. Nalini<sup>1</sup>, S. Saravanan<sup>2</sup>, K. Raghukandan<sup>3</sup>**

<sup>1</sup>Department of Computer Science and Engineering, Annamalai University, Annamalainagar.

<sup>2</sup>Department of Mechanical Engineering, Annamalai University, Annamalainagar.

<sup>3</sup>Department of Manufacturing Engineering, Annamalai University, Annamalainagar.

### **Corresponding author**

**K.Gajalakshmi**

Department of Computer Science and Engineering

Annamalai University

Email: gajusaran@gmail.com

Phone: +91-9150610187

### **Abstract**

The objective of this study is to develop an image processing algorithm to determine the average grain size in a metallic microstructure by counting the number of grains using support vector regression (SVR). Automatic grain size measurement algorithm is implemented in the microstructural analysis to attain high speed along with accuracy than manual methods. The grain boundaries of various metals were determined using Otsu and canny edge detection techniques. The edge detected image is divided into blocks and the number of white to black transitions in each block is used as feature. The extracted features are used to train the support vector machine in regression mode. The number of grains in test image is determined using support vector regression. The accuracy of developed algorithm is verified using the manual intercept method. The experimental results show that the canny edge detection based feature

متن کامل مقاله

دریافت فوری ←

**ISI**Articles

مرجع مقالات تخصصی ایران

- ✓ امکان دانلود نسخه تمام متن مقالات انگلیسی
- ✓ امکان دانلود نسخه ترجمه شده مقالات
- ✓ پذیرش سفارش ترجمه تخصصی
- ✓ امکان جستجو در آرشیو جامعی از صدها موضوع و هزاران مقاله
- ✓ امکان دانلود رایگان ۲ صفحه اول هر مقاله
- ✓ امکان پرداخت اینترنتی با کلیه کارت های عضو شتاب
- ✓ دانلود فوری مقاله پس از پرداخت آنلاین
- ✓ پشتیبانی کامل خرید با بهره مندی از سیستم هوشمند رهگیری سفارشات